

Parity Violating Deep Inelastic Scattering at 6 GeV

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The Physics of PVDIS

Experimental Setup and General Run Information

Online Results and Expected Uncertainties

On-Going Data Analysis

➤ BCM Calibration

➤ Deadtime of the Fast-Counting DAQ

Summary

The Physics of PVDIS at 6 GeV (E08-011)

Measure PVDIS asymmetry on a deuterium target, A_d , at $Q^2=1.10$ and 1.90 GeV^2 to 2% (stat.);

$$A_{pv} \equiv \frac{\sigma^r - \sigma^l}{\sigma^r + \sigma^l} = \frac{(M_y + M_Z^r)^2 - (M_y + M_Z^l)^2}{(M_y + M_Z^r)^2 + (M_y + M_Z^l)^2} \approx \frac{M_Z^r - M_Z^l}{M_y}$$

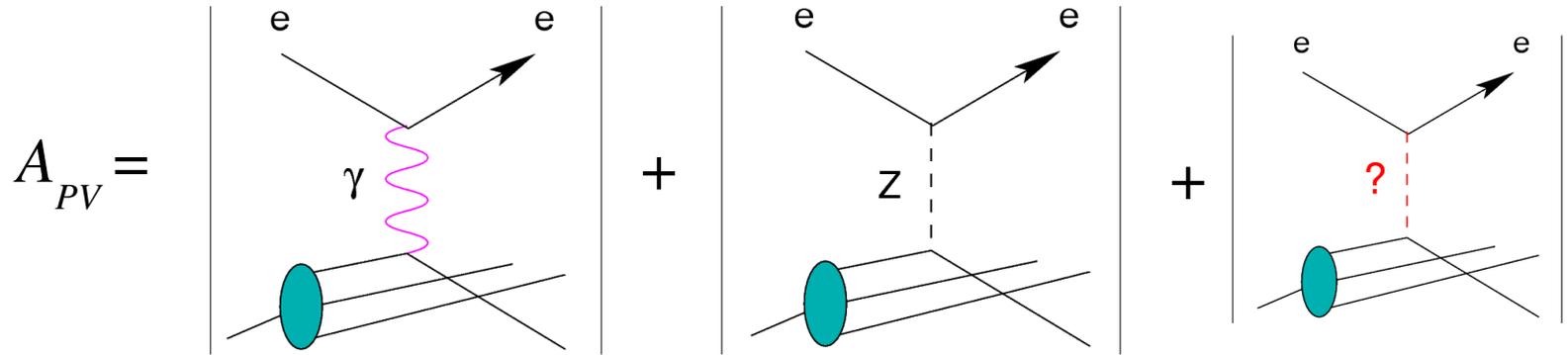
From $Q^2=1.10$ can help to investigate if there are significant HT effects;

— “Baseline” measurement for the future 12 GeV program.

If HT is small, from $Q^2=1.90$ GeV^2 can extract $2C_{2u} - C_{2d}$ to ± 0.060 , a factor of 4.1 improvement

Kinematics	x_{bj}	Q^2 (GeV/c) ²	E_{beam} (GeV)	E' (GeV)	θ (°)	W^2 (GeV) ²	A_d (ppm)
I	0.25	1.11	6.0	3.66	12.9°	4.16	-91.3
II	0.3	1.9	6.0	2.63	20.0°	5.3	-160.7

PVDIS Asymmetries



Deuterium:

$$A_d = (540 \text{ ppm}) Q^2 \frac{2C_{1u}[1+R_C(x)] - C_{1d}[1+R_S(x)] + Y(2C_{2u} - C_{2d})R_V(x)}{5 + R_S(x) + 4R_C(x)}$$

$$C_{1u} = g_A^e g_V^u = -\frac{1}{2} + \frac{4}{3} \sin^2(\theta_W)$$

$$C_{2u} = g_V^e g_A^u = -\frac{1}{2} + 2 \sin^2(\theta_W)$$

$$C_{1d} = g_A^e g_V^d = \frac{1}{2} - \frac{2}{3} \sin^2(\theta_W)$$

$$C_{2d} = g_V^e g_A^d = \frac{1}{2} - 2 \sin^2(\theta_W)$$

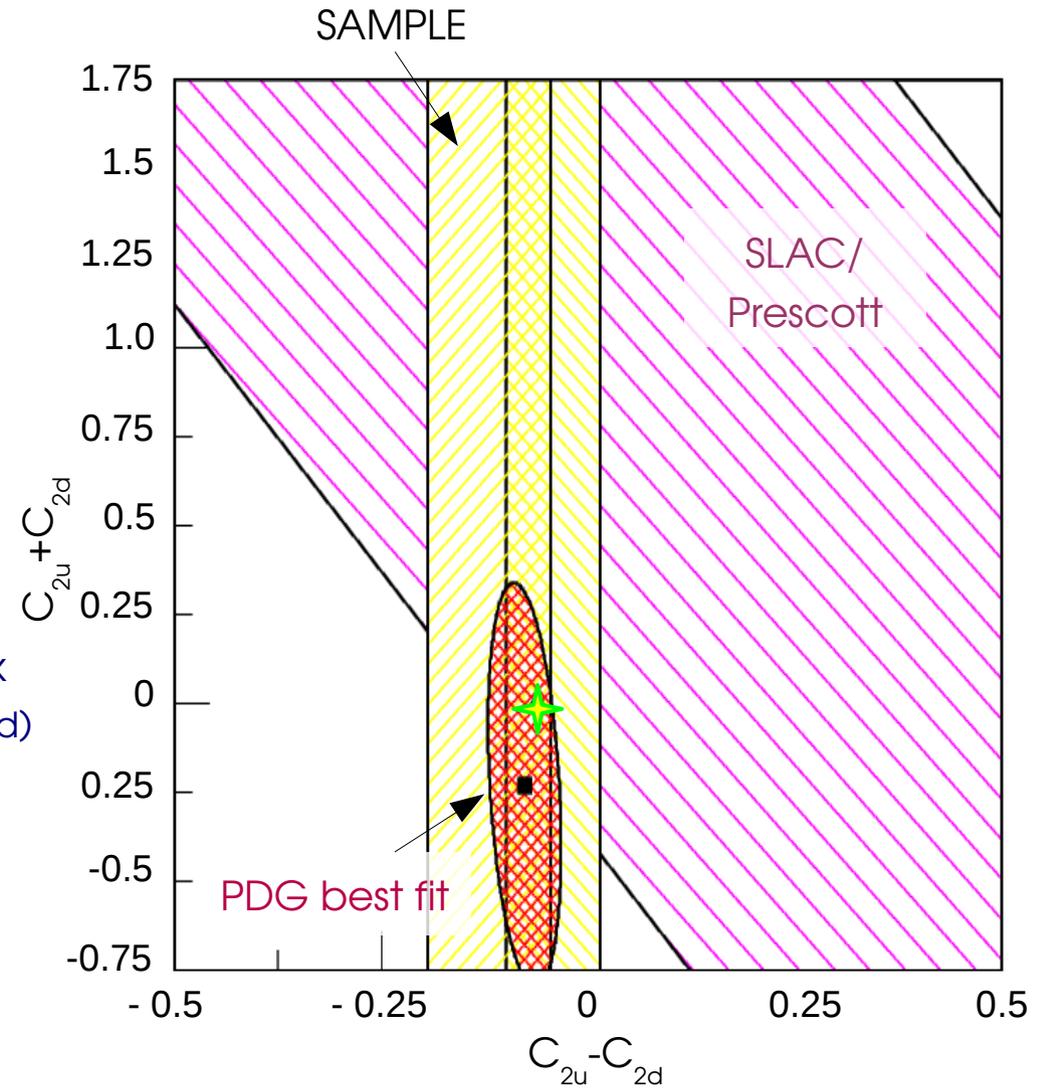
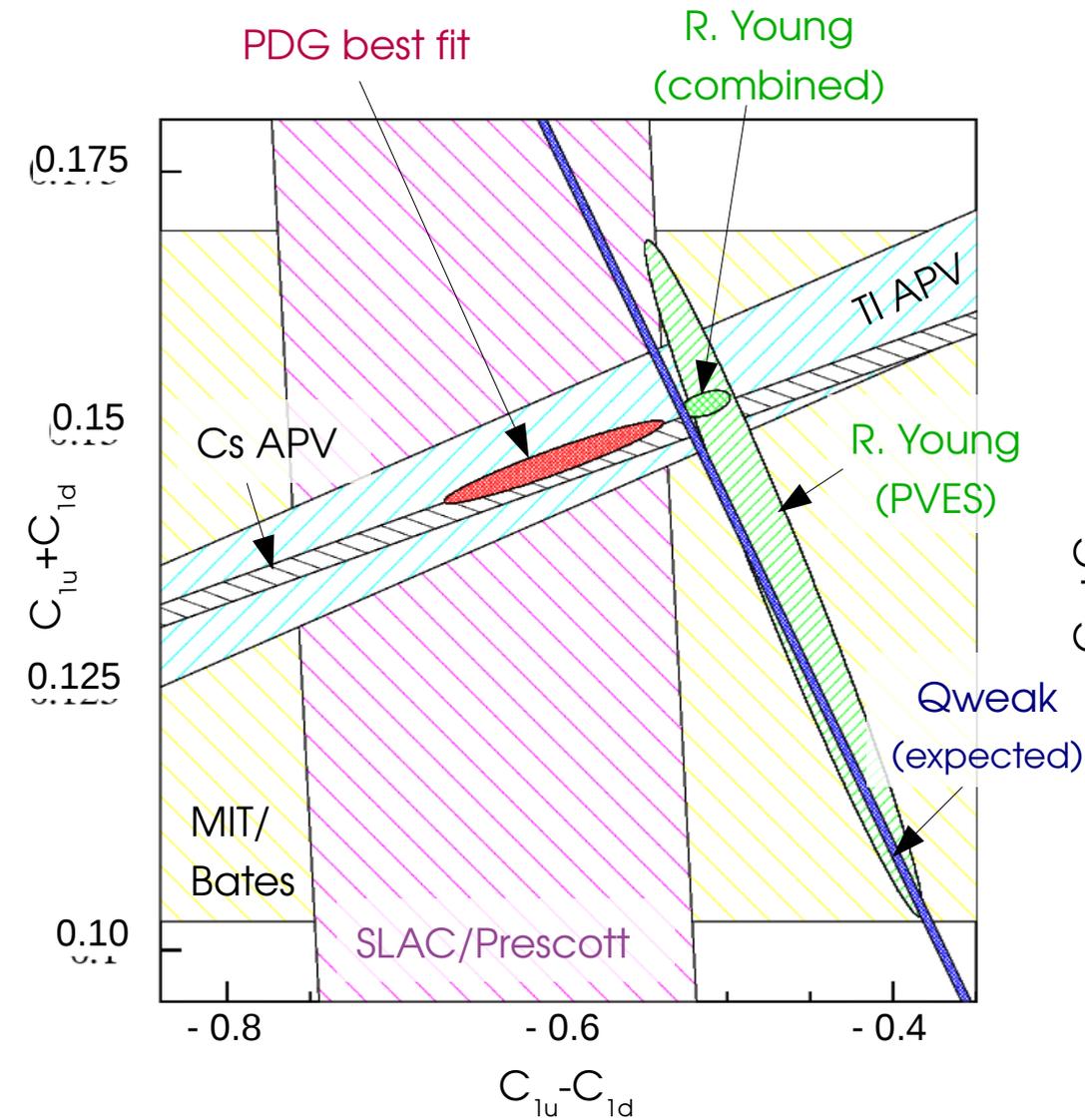
Can extract $C_{1,2q}$ (and $\sin^2\theta_W$) – discover new physics beyond the SM

Mass limit:

$$\frac{\Lambda}{g} \approx \frac{1}{\left[\sqrt{8} G_F \left| \Delta(2C_{2u} - C_{2d}) \right| \right]^{1/2}} \approx 0.74 \text{ TeV}$$

Current Knowledge on $C_{1,2q}$

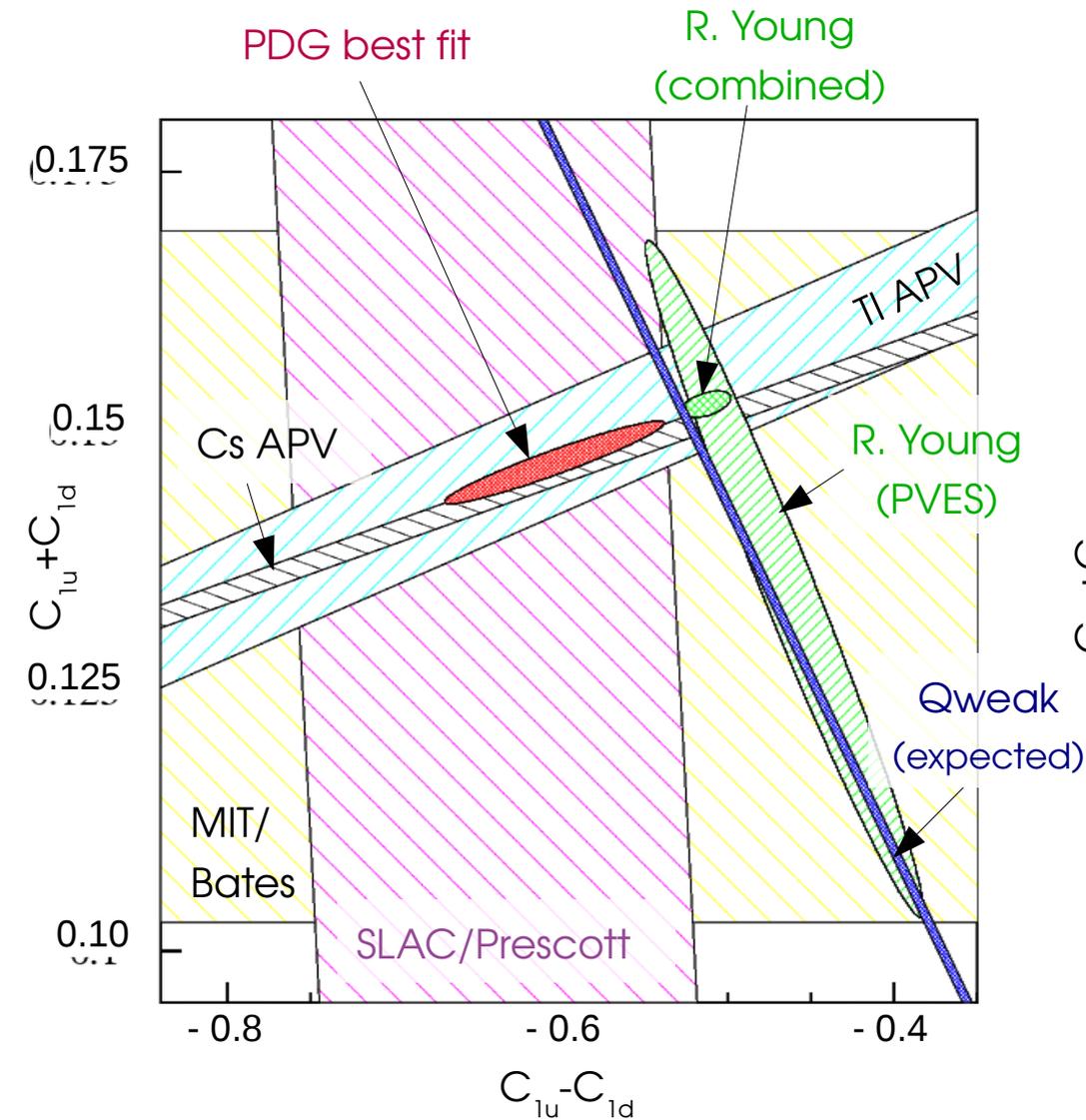
all are 1σ limit



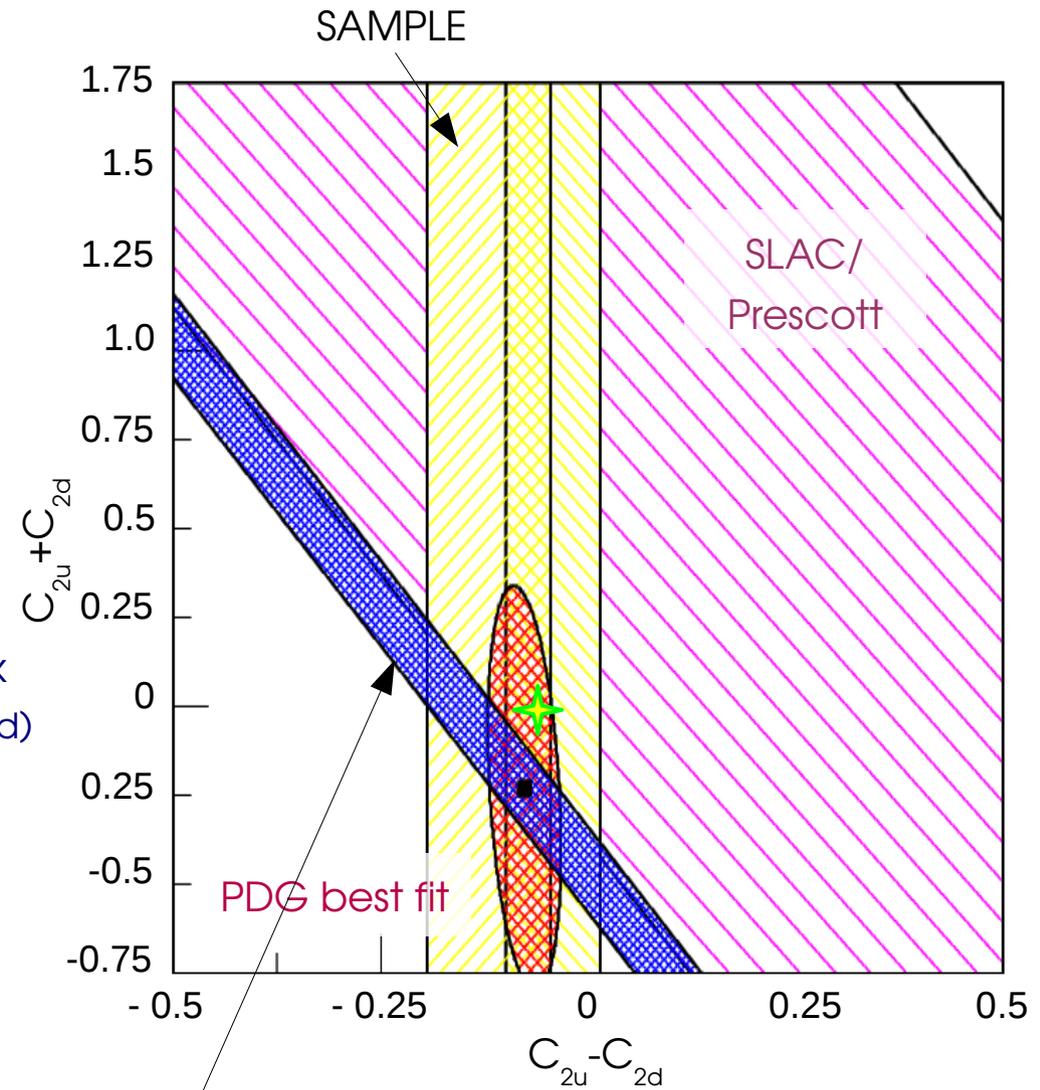
Best: $\Delta(2C_{2u} - C_{2d}) = 0.24$

The 6 GeV E08-011

all are 1 σ limit



Best: $\Delta(2C_{2u} - C_{2d}) = 0.24$

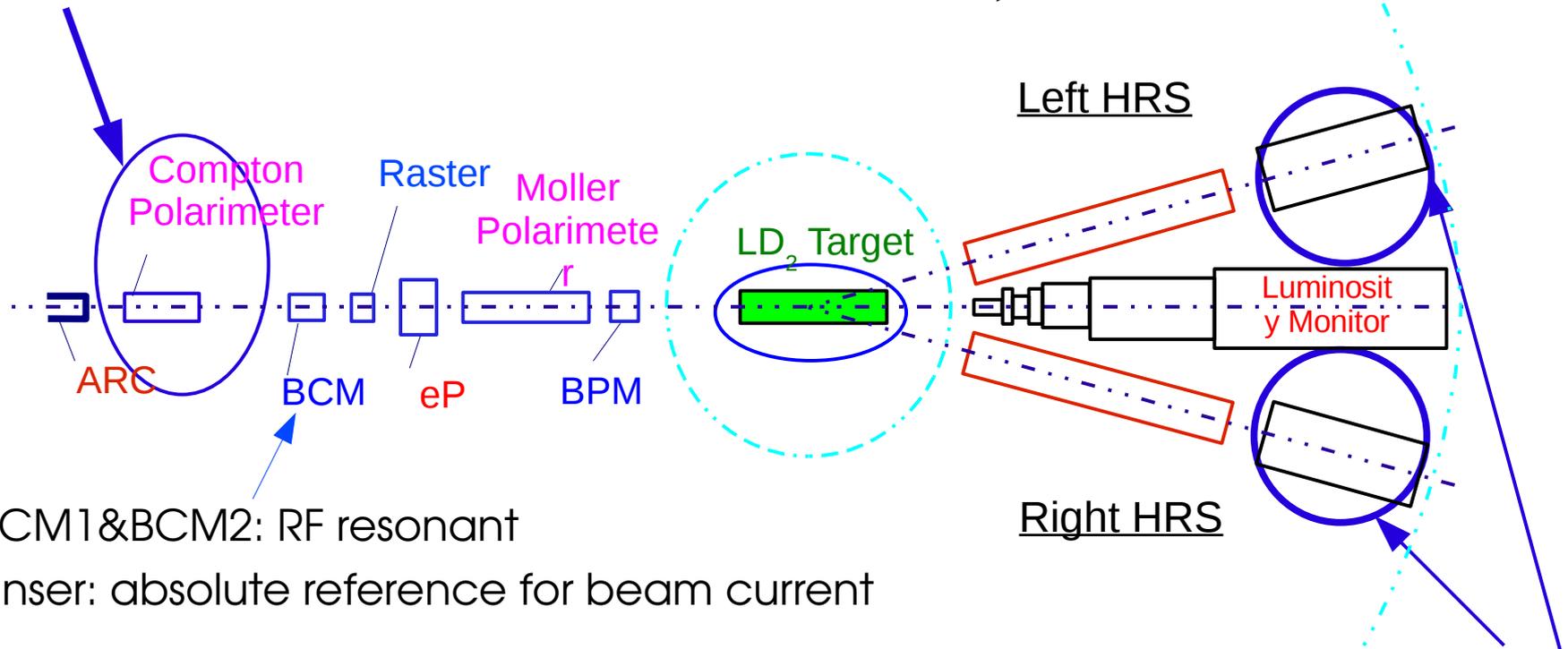


Expected: JLab 6 GeV PV-DIS E08-011
(assuming small hadronic effects and a 4% stat error on A_d)

Overview of the Experimental Setup in Hall A

Expected Precision: 1~2%

fast-counting DAQ, design goal:
1MHz; (scaler-based, partially w/
FADC)



- + Regular HRS data acquisition (DAQ) count up to 4KHz (expect 500KHz);
- + Integration method won't work for DIS;
- + Need a new fast-counting DAQ, design goal: 1MHz with on-line particle identification (PID)

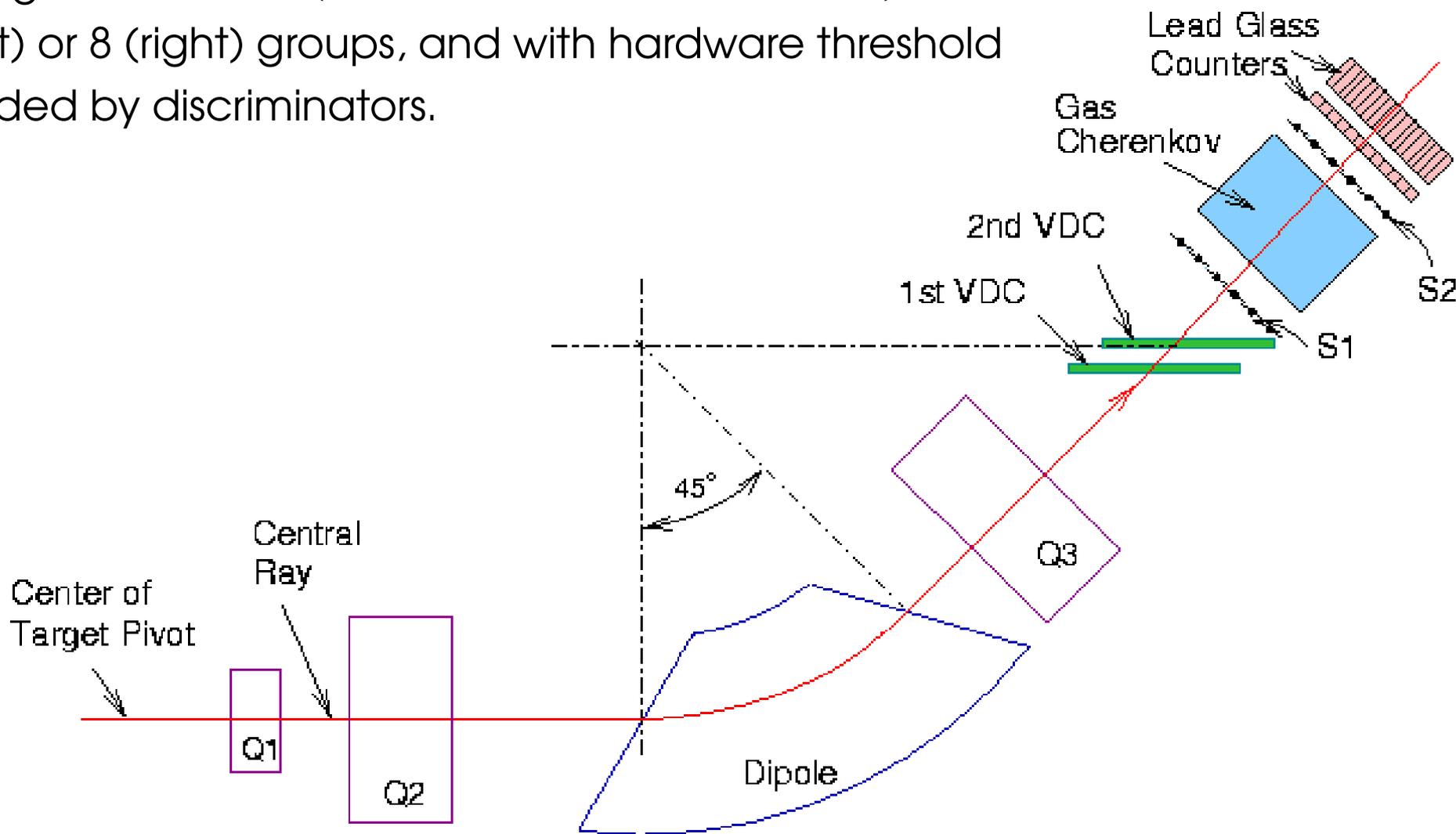
A new fast-counting DAQ

Inputs:

Scintillators ("T1");

Gas cherenkov (GC), with hardware threshold provided by discriminators.

Lead glass counters ("Pre-shower" and "Shower"), divided into 6 (left) or 8 (right) groups, and with hardware threshold provided by discriminators.

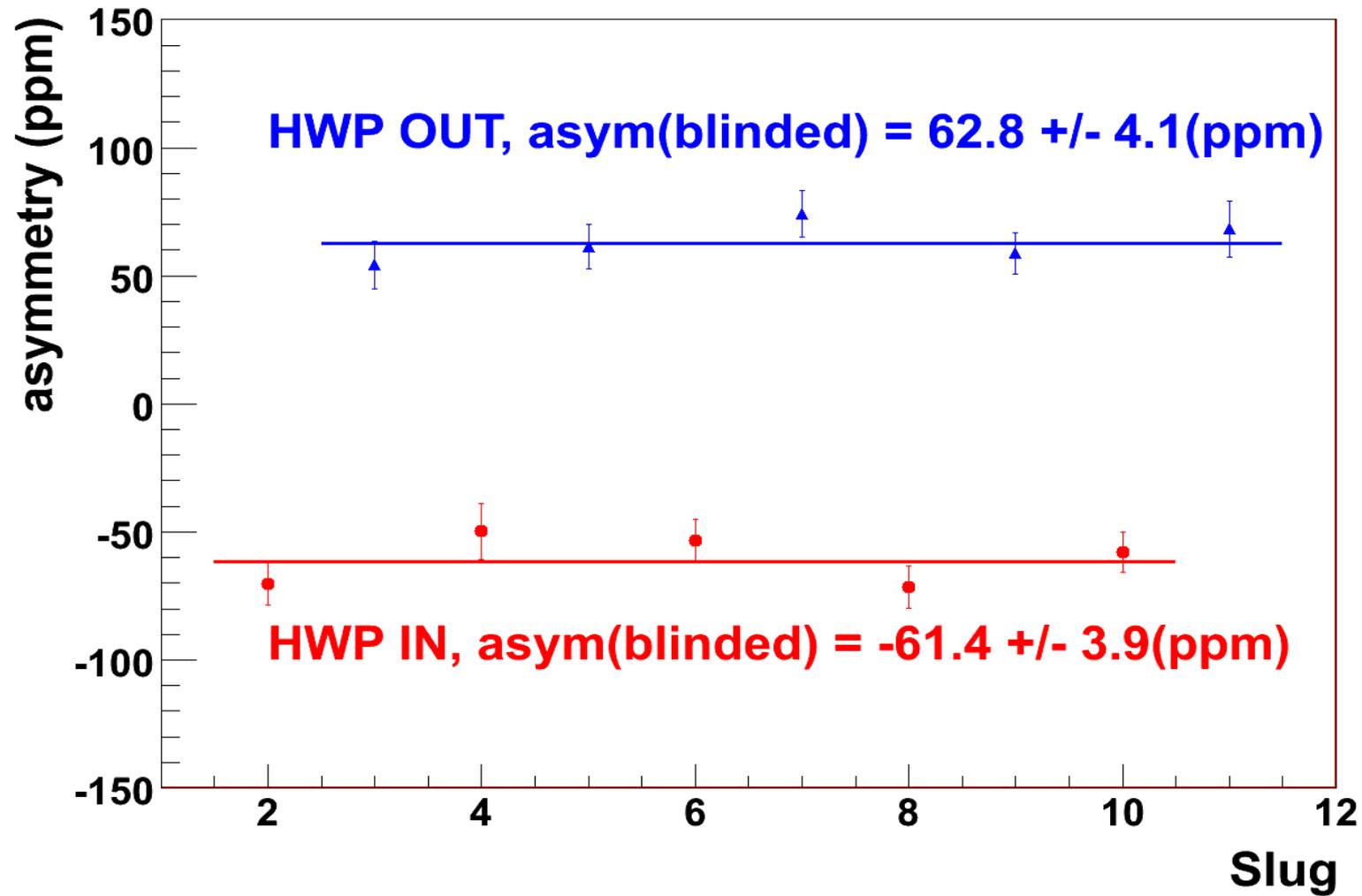


PVDIS General Run Information

- ➔ Beam polarization shared with Hall B and monitored by Moller and Compton (photon-only). Moller results ~87%;
- ➔ Beam vertical polarization measured to be <2%;
- ➔ Beam charge asymmetry controlled by “parity feedback”;
- ➔ Target boiling noise monitored by Lumi;
- ➔ Beam IHWP switched every 1M helicity pairs (1 pair=66ms) (“slugs”);
- ➔ Deadtime measurement, analysis in progress;
- ➔ Other background or systematics measurements:
 - Pion asymmetries measured continuously by PVDIS DAQ, consistent with zero so far;
 - Al dummy and positive polarity runs (8 hours), rates agree with calculations;
 - Transverse beam polarization running (12 hours), *best DIS transverse measurement so far*, systematic uncertainty under control;
 - Random coincidence measurements.

Online Asymmetries, Q2=1.1, Left Arm Only

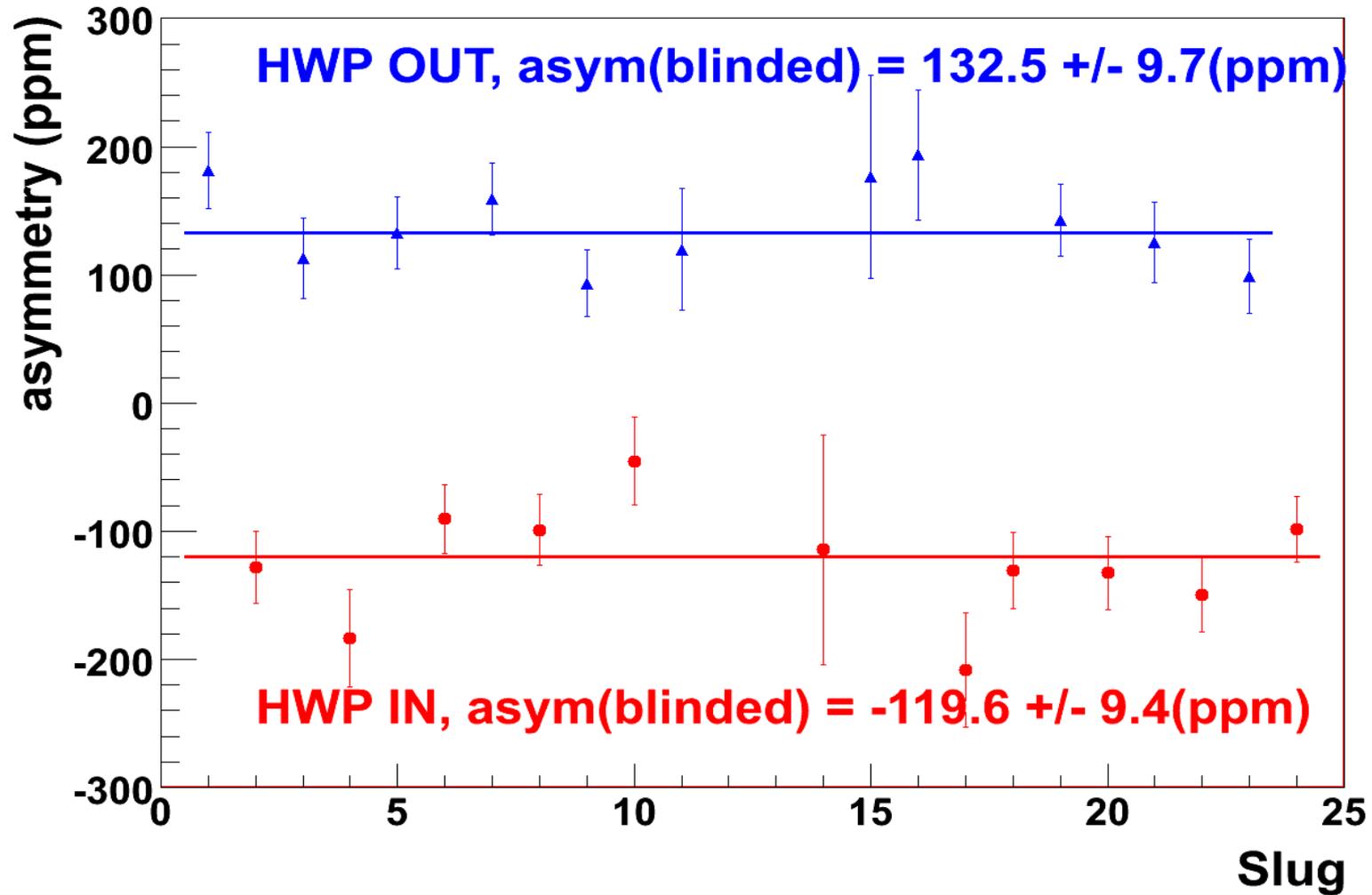
asymmetries of left arm, P0 = 3.66GeV



$$\text{Statistical Error} \approx (4.0/\sqrt{(2)})/91.3 \approx 3.0\%$$

Online Asymmetries, Q2=1.9, Right Arm

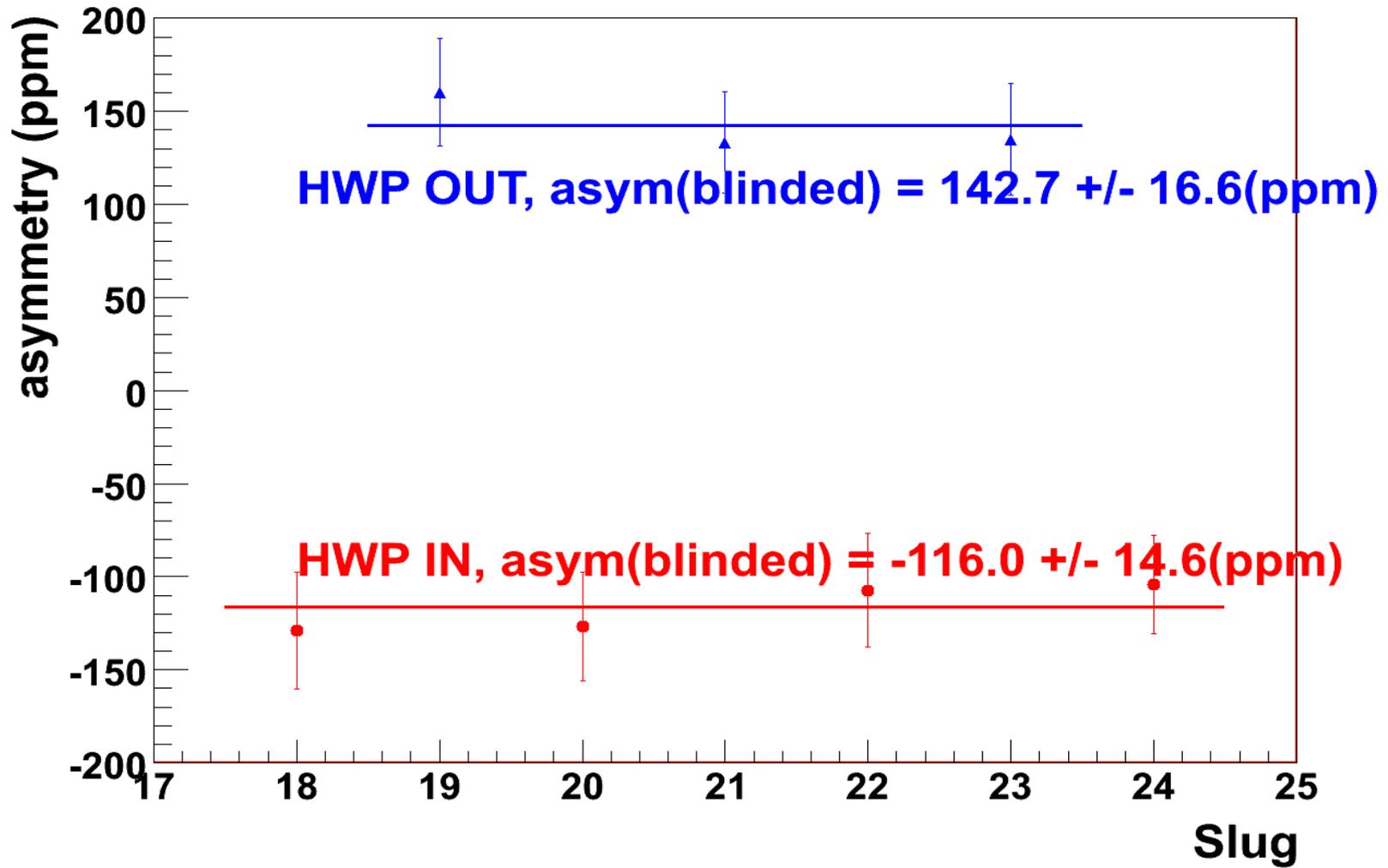
asymmetries of right arm, P0 = 2.63GeV



$$\text{Statistical Error} \approx (9.6 / \sqrt{2}) / 160.7 \approx 4.0\%$$

Online Asymmetries, Q2=1.9, Left Arm

asymmetries of left arm, P0 = 2.63GeV



Expected Uncertainties on A_d

Source \ $\Delta A_d/A_d$	$Q^2=1.1 \text{ GeV}^2$	$Q^2=1.9 \text{ GeV}^2$
$\Delta P_b/P_b=2\%$	2.0%	2.0%
Deadtime correction	0.3%	0.3%
Target endcap contamination	0.4%	0.4%
Target purity	<0.02%	<0.02%
Pion background	<0.2%	<0.2%
Pair production background	<0.2%	<0.2%
Systematics	2.08%	2.08%
Statistical	3.0%	4.0%
Total	3.7%	4.5%

BCM Calibration

★ Goal

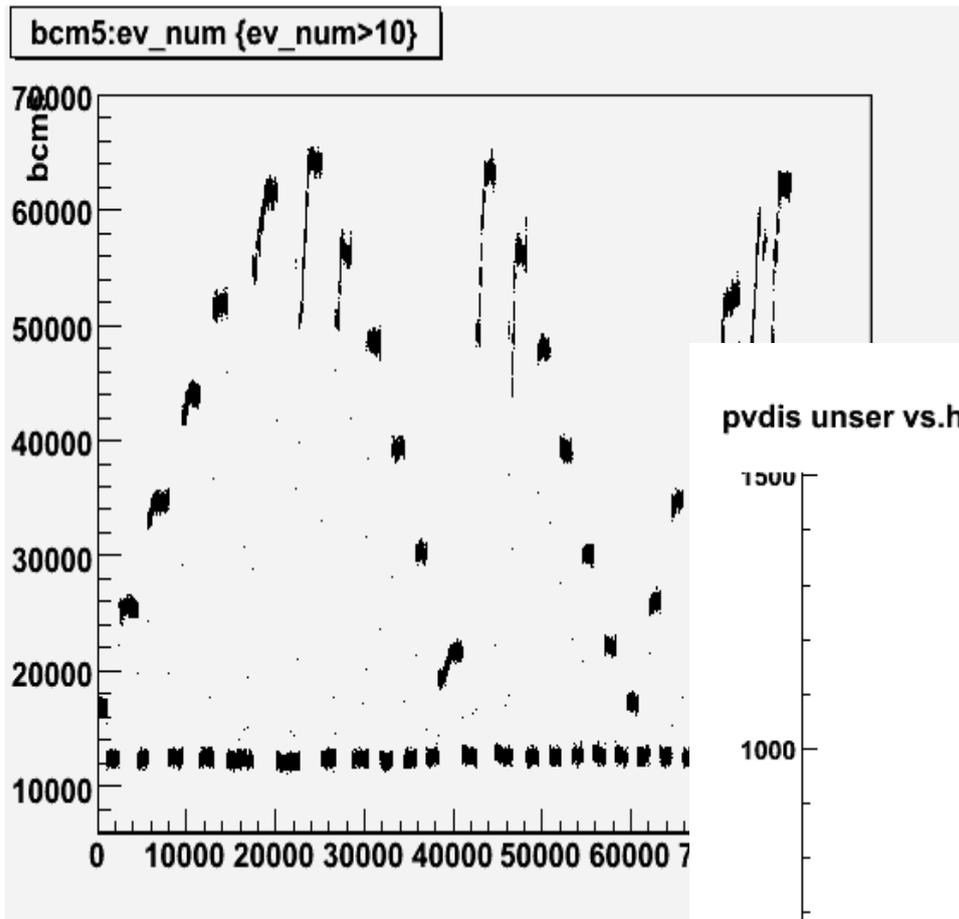
To determine the linearity of BCMs and its effect on the rate-scan method of the deadtime

★ Background

- ➔ Beam current measured by two BCMs, 25m upstream of the target
- ➔ In between is Unser Monitor which provides an absolute measurement of the current
- ➔ Unser Monitor not used for continuous current monitoring, since its output signal drifts during a period of several minutes

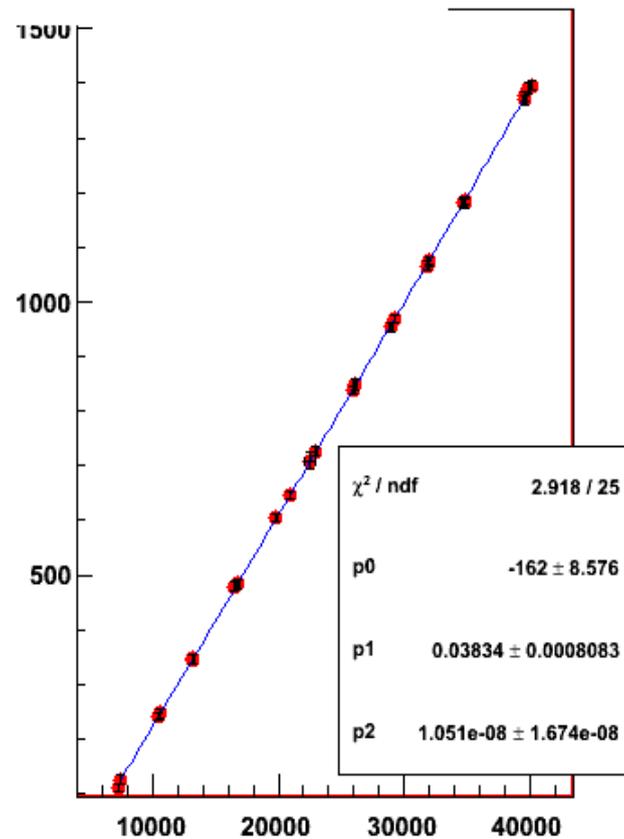
$$I_{unser} = A + B \times BCM + C \times BCM^2$$

BCM Calibration

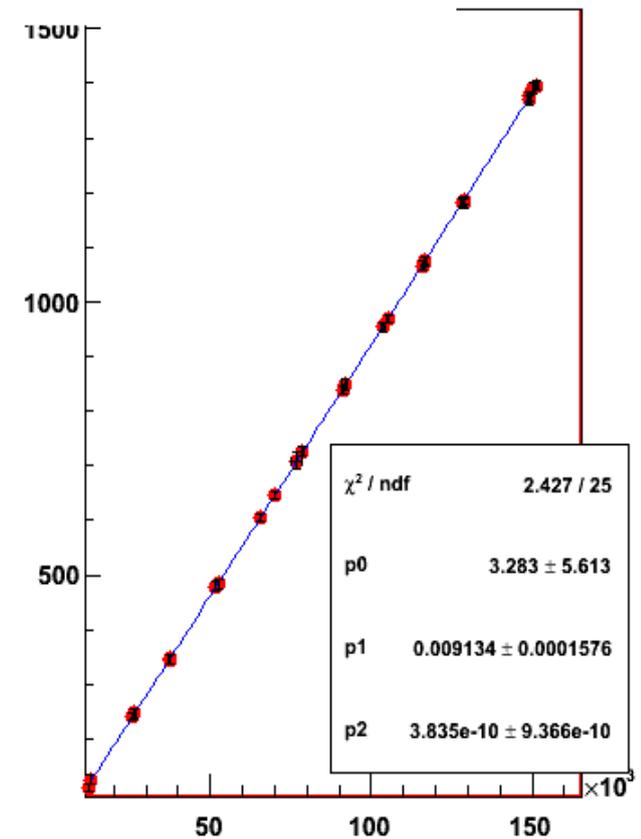


Unser vs time

pvdiss user vs.happex bcmu1

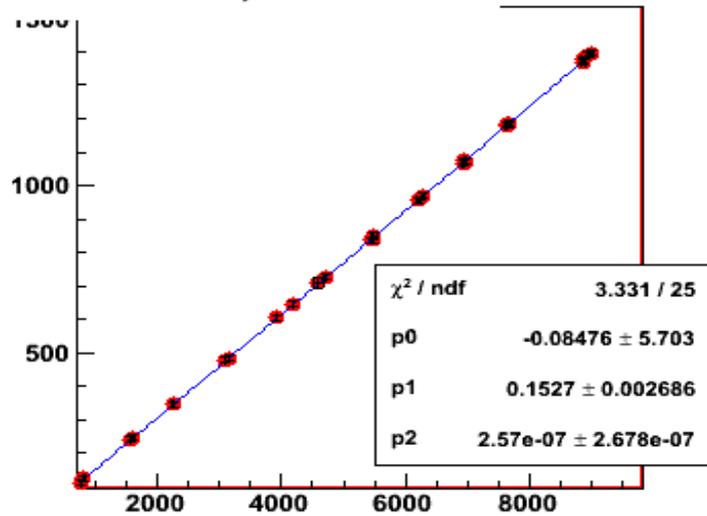


pvdiss user vs.happex bcmu1

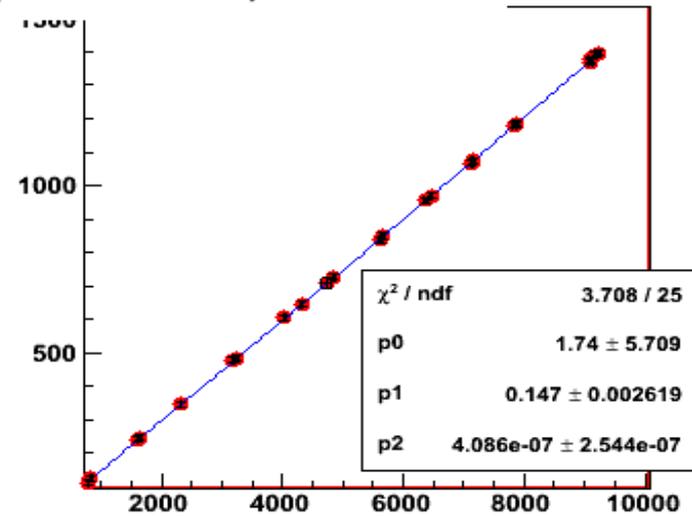


BCM Calibration

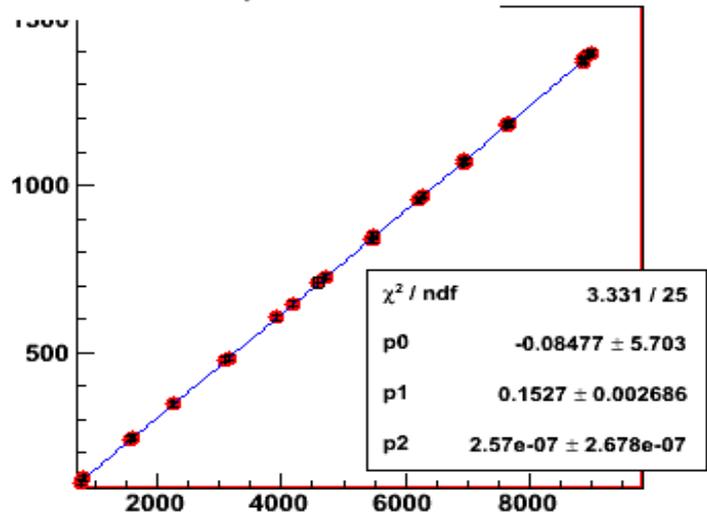
pvdis user vs pvdisR bcm u1



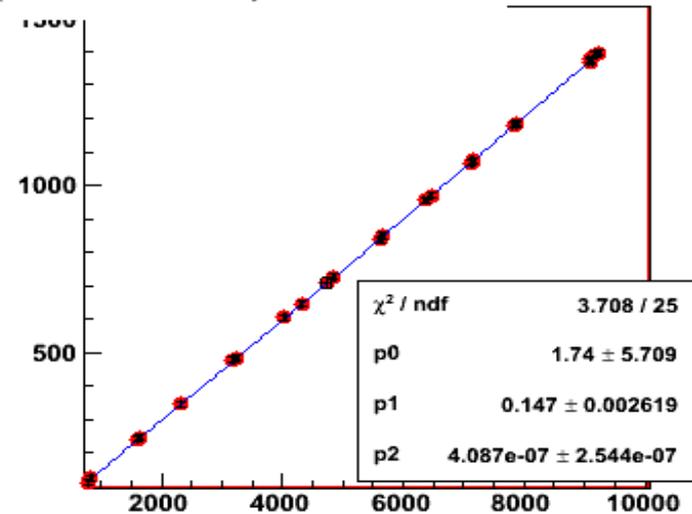
pvdis user vs pvdisR bcm d1



pvdis user vs pvdisL bcm u1



pvdis user vs pvdisL bcm d1



Unser vs scaler readings of BCMs in PVDIS DAQ

Deadtime of the Fast-Counting DAQ

- Deadtime measured by multiple methods (goal: 0.3%)
- Two resolution time (20, 100ns), rate scan
- “tagger”, TDC system

$$A_{PV} = \frac{A_{measured}}{P_b \eta_{DT}}$$

Deadtime of the Fast-Counting DAQ

Rate Scan method to measure the deadtime

Ideally

$$Rate = aI(1 - DT) \quad DT = aI \times w$$

Where a is a positive constant related to cross section, acceptance and etc. w is deadtime expressed in width.

Then

$$\frac{Rate}{I_{unser}} = a(1 - aw \times I)$$

So we can plot Rate/ I vs I by using BCM calibration result:

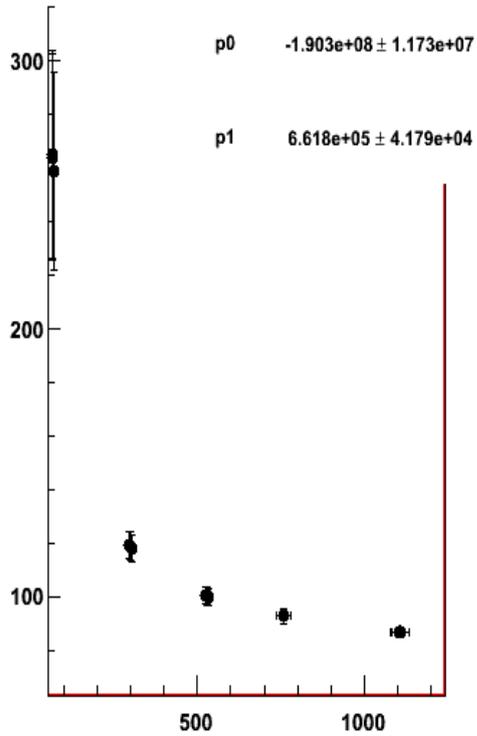
$$I_{unser} = A + B \times BCM + C \times BCM^2$$

w can be expressed by the fitting results

$$w = -pol1 / pol0^2$$

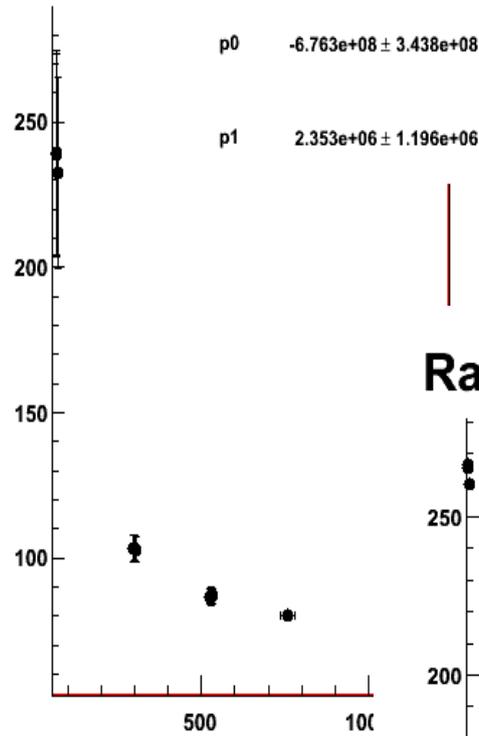
Deadtime of the Fast-Counting DAQ

Rate(T1)/I vs.I 4542 / 11



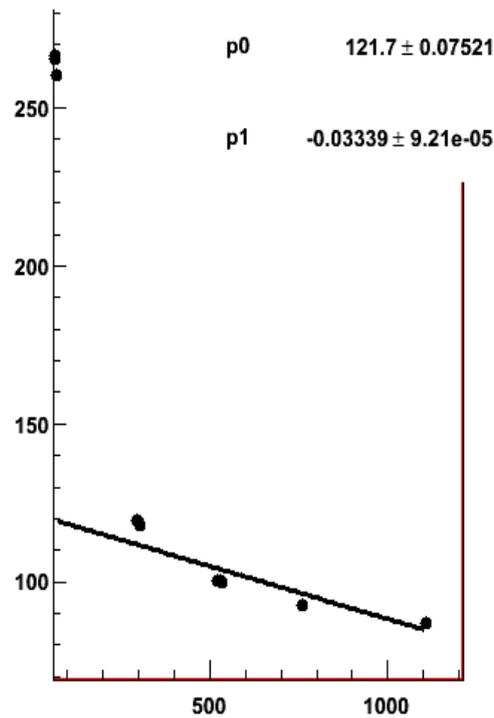
$$\sigma = RMS$$

Rate(GC)/I vs.I 4542 / 11

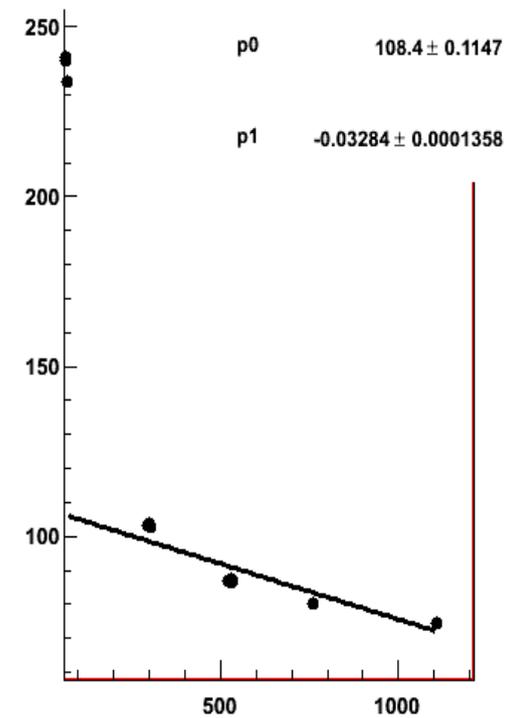


$$\sigma = RMS / \sqrt{N}$$

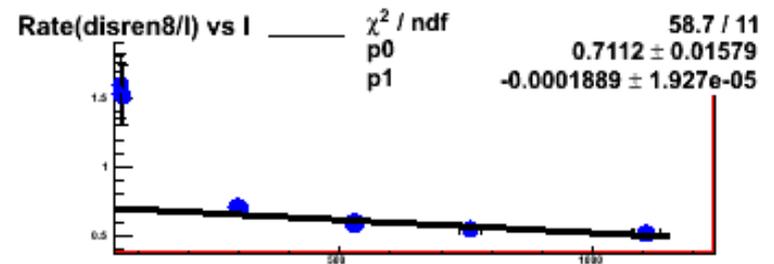
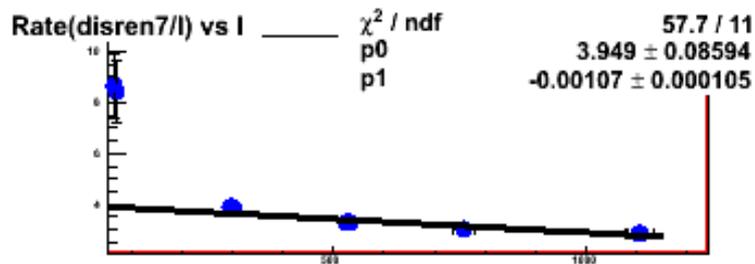
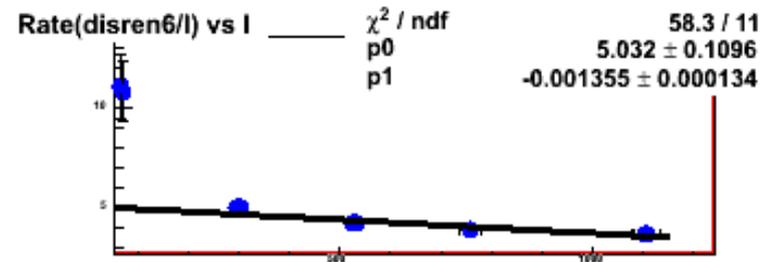
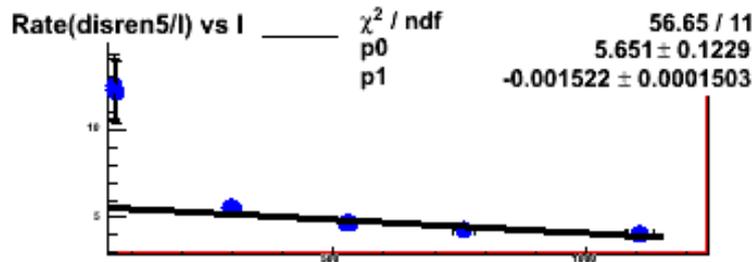
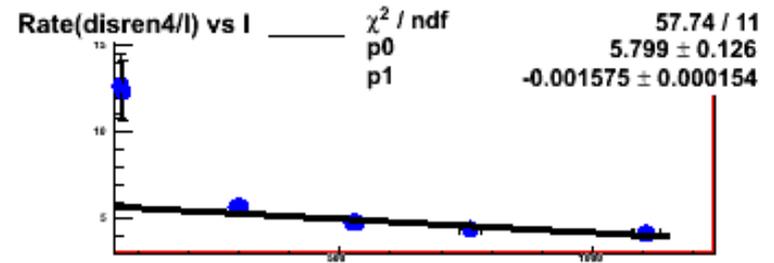
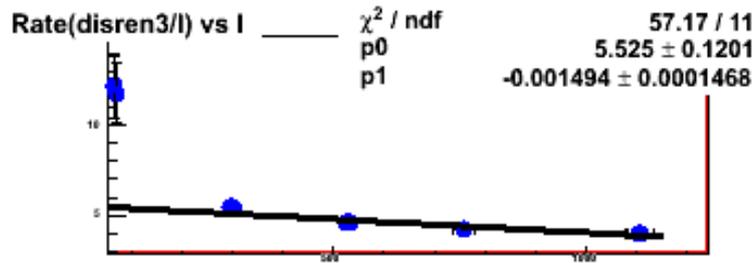
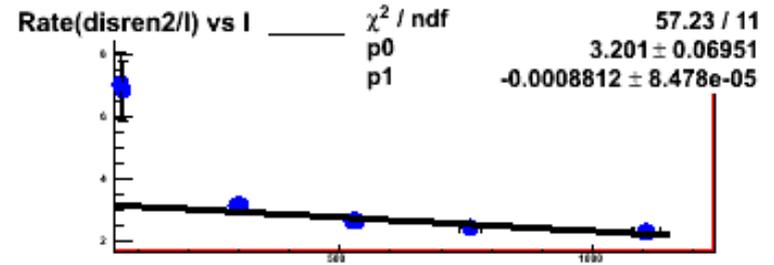
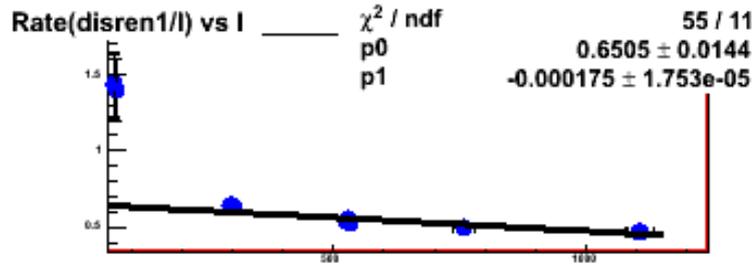
Rate(T1)/I vs.I 9.668e+04 / 11



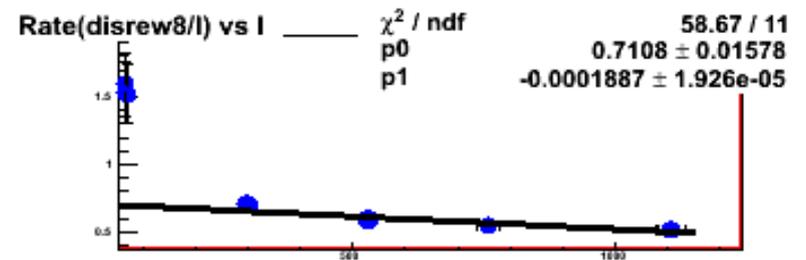
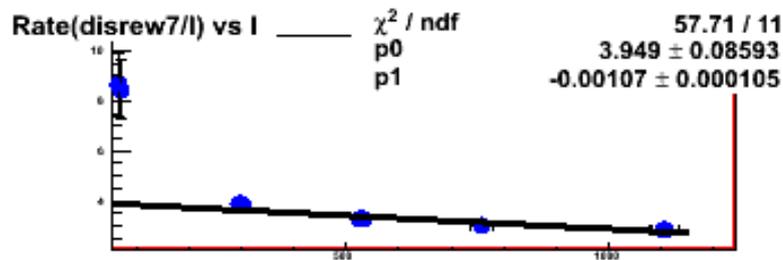
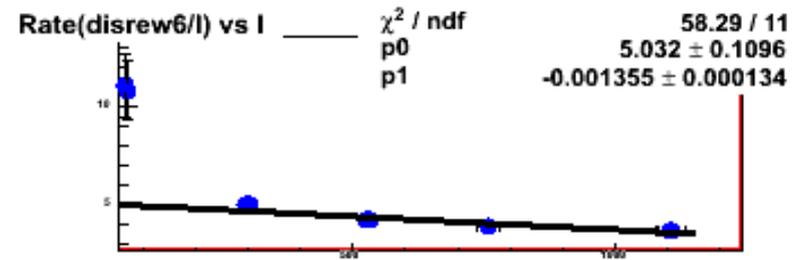
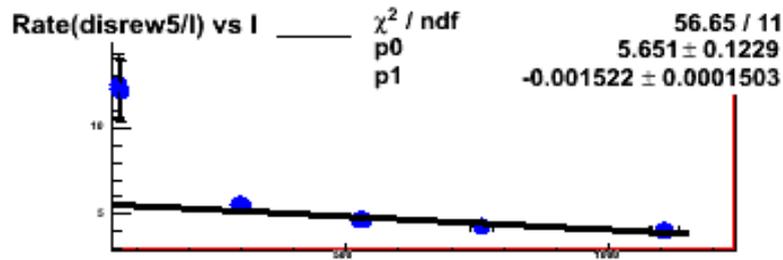
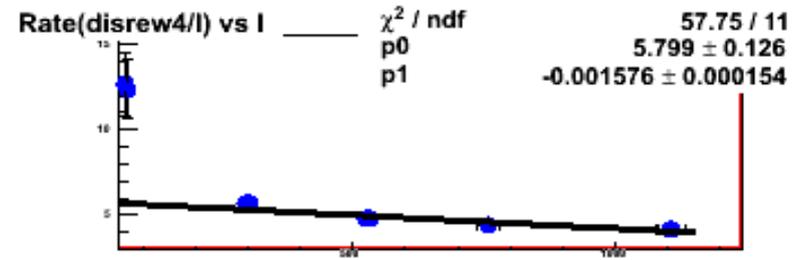
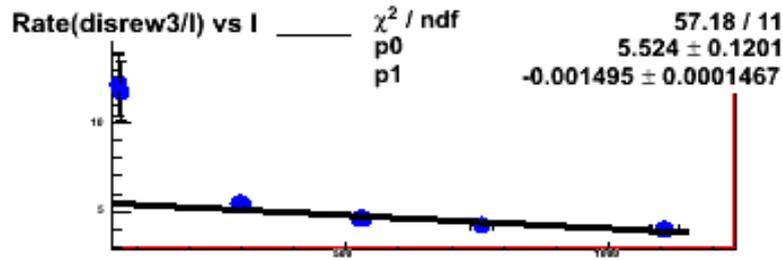
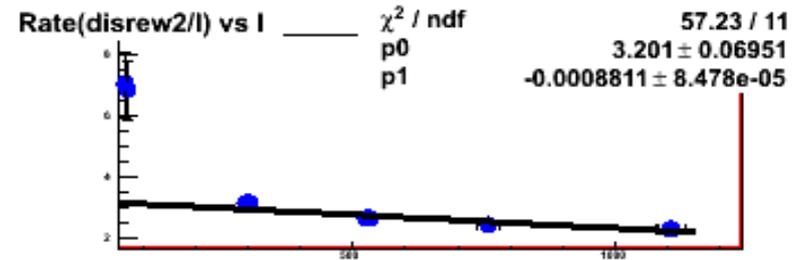
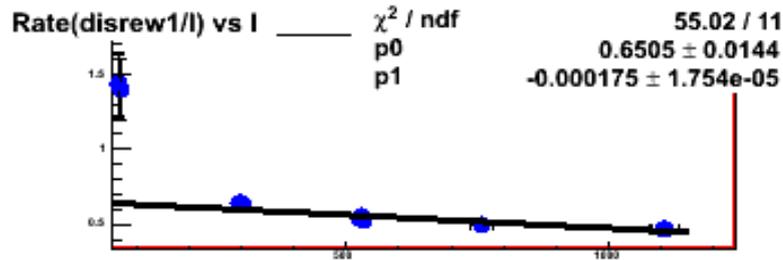
Rate(GC)/I vs.I 5.283e+04 / 11



Deadtime of the Fast-Counting DAQ

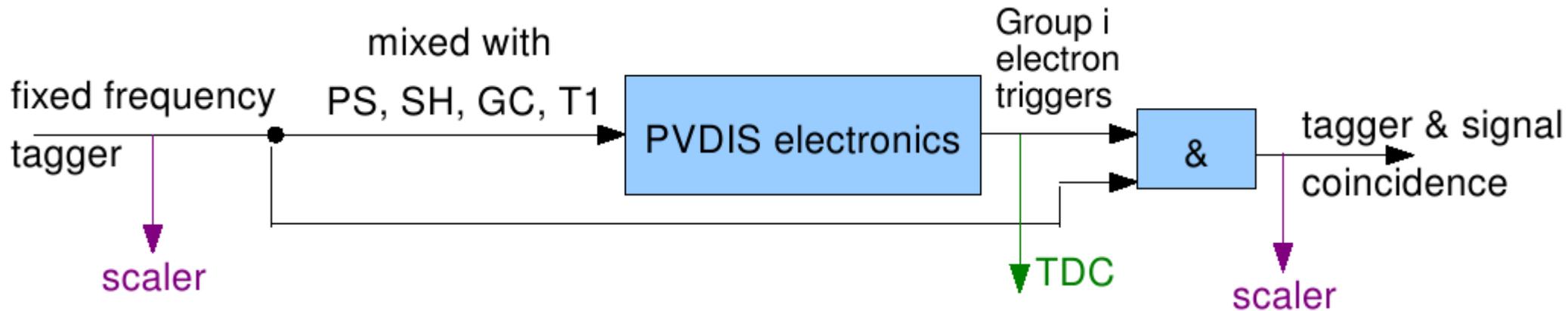


Deadtime of the Fast-Counting DAQ



Deadtime of the Fast-Counting DAQ

The Tagger method to measure deadtime:



$$Deadtime = \frac{R_{tagger} - R_{tagger \& signal} (1 - Pileup)}{R_{tagger}} \approx \frac{R_{tagger} - R_{tagger \& signal}}{R_{tagger}} + Pileup$$

$$\equiv \text{Fractional Loss} + Pileup$$

Measured by scaler

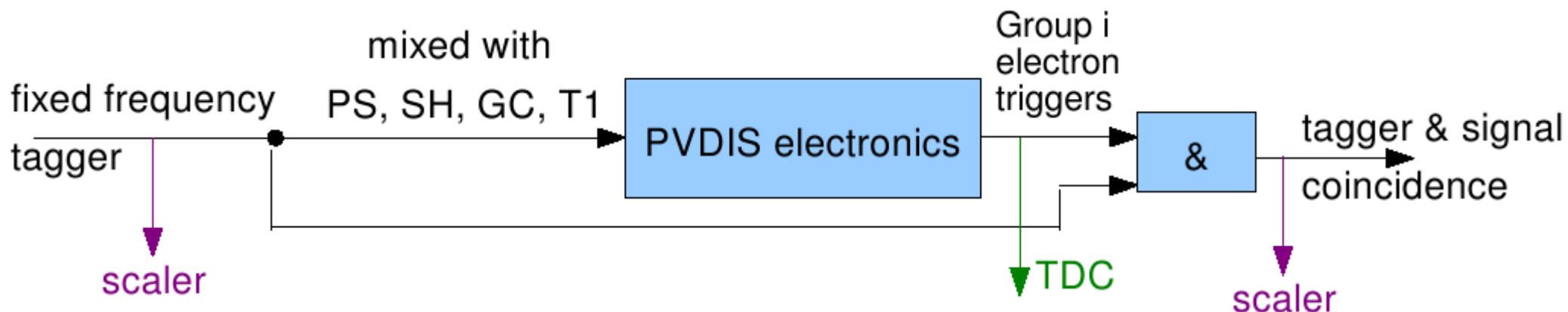
Different for narrow and wide path

Measured by TDC

Same for narrow and wide path

Deadtime of the Fast-Counting DAQ

The Tagger method to measure deadtime:



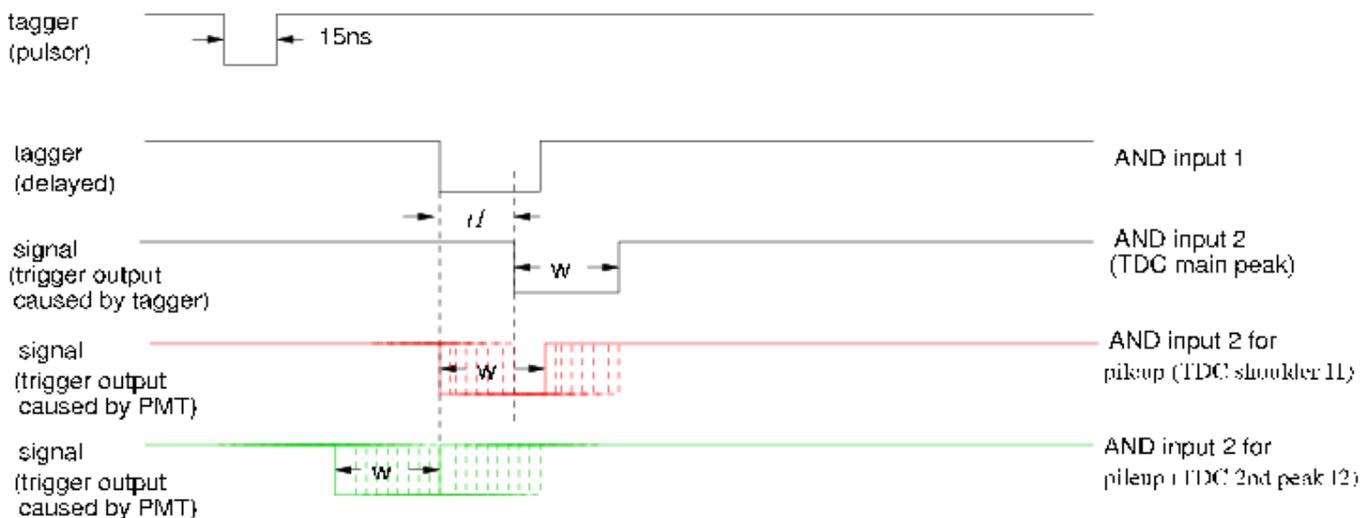
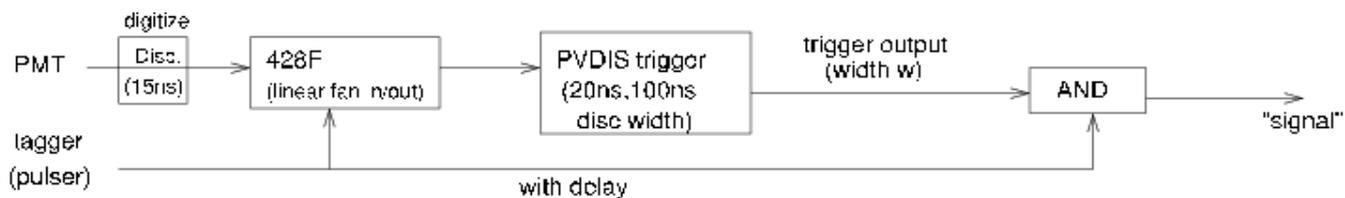
$$\text{Deadtime} = \frac{R_{\text{tagger}} - R_{\text{tagger \& signal}} (1 - \text{Pileup})}{R_{\text{tagger}}} \approx \frac{R_{\text{tagger}} - R_{\text{tagger \& signal}}}{R_{\text{tagger}}} + \text{Pileup}$$
$$\equiv \text{Fractional Loss} + \text{Pileup}$$

In theory: $\text{Deadtime}(\%) = \text{Rate} \times \text{Width}$

Where Width is the **widest** width through the whole path

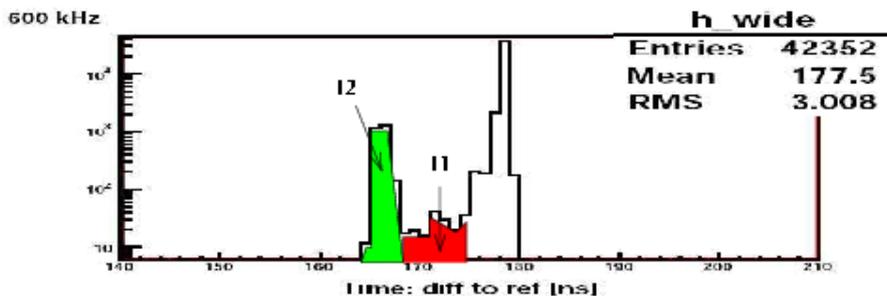
- For wide path, width = 100ns
- For narrow path, width = signal width ~ 60ns

Deadtime of the Fast-Counting DAQ



$$I1=R*t1$$

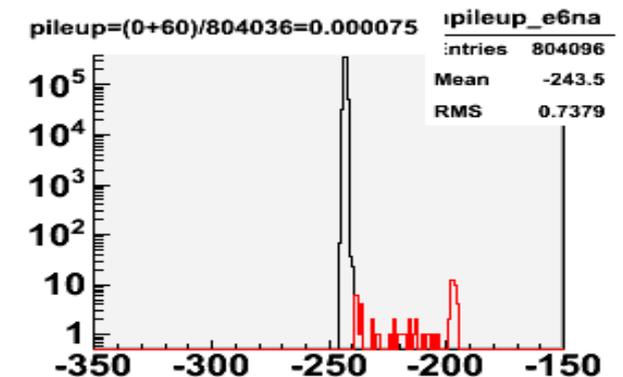
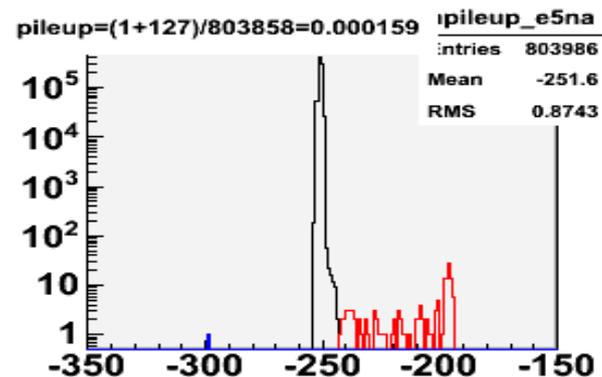
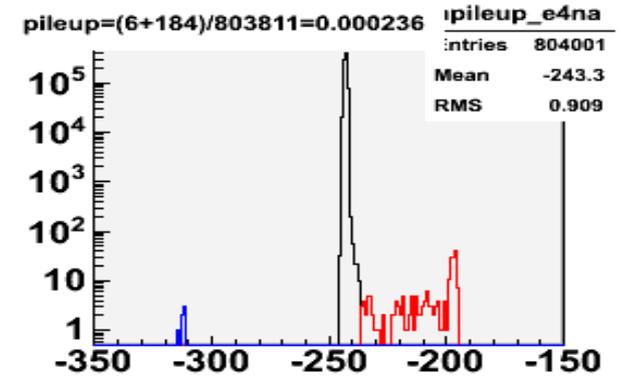
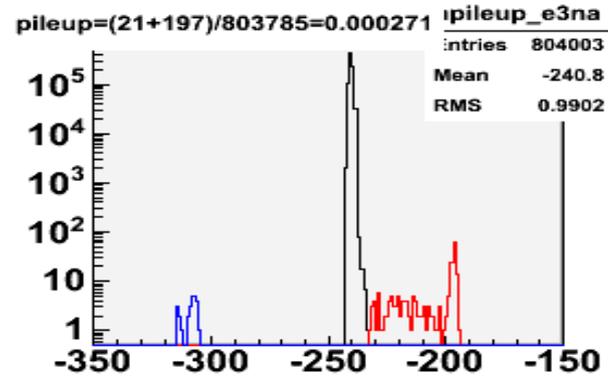
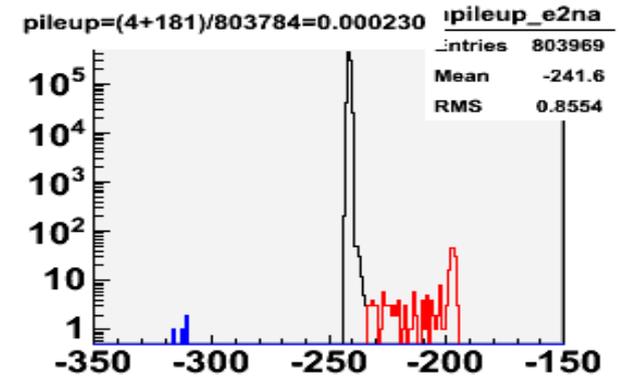
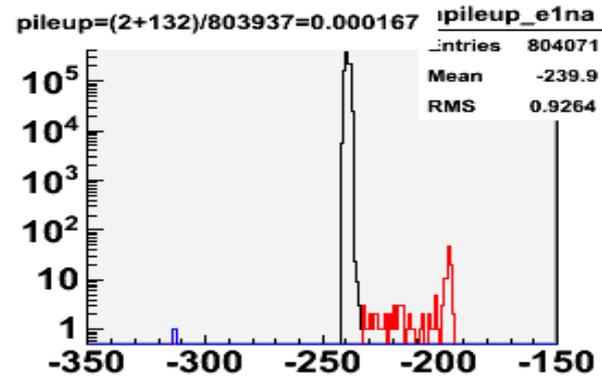
$$I2=R*w$$



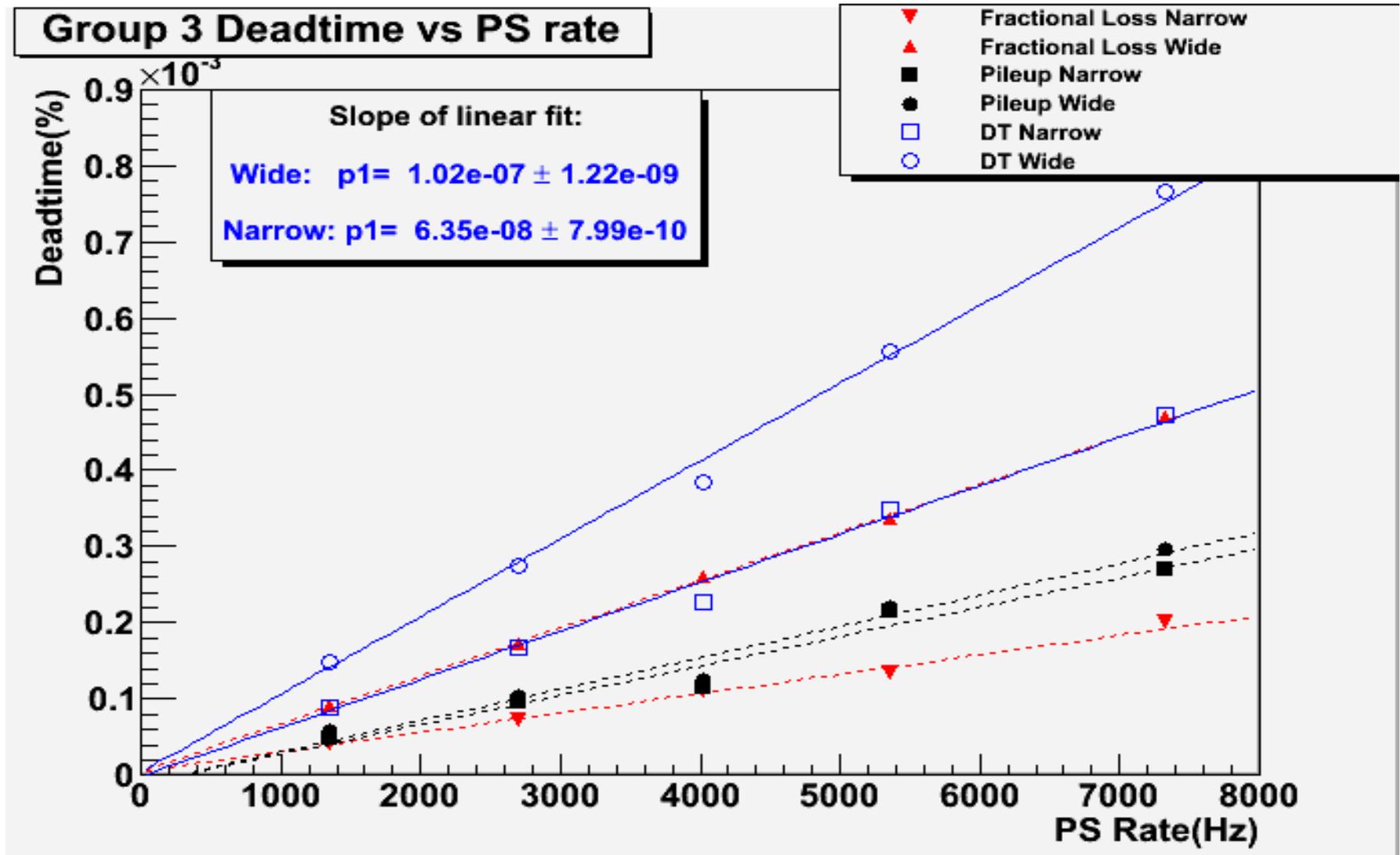
Pileup effect: when the tagger signal follows closely a random PMT signal, the DAQ output caused by the PMT signal would co-incide with the tagger signal, causing a false count that should have lost due to deadtime

TDC Pileup Spectrum

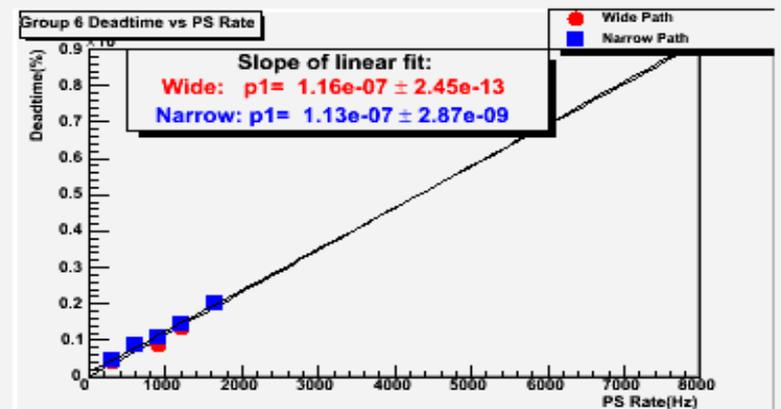
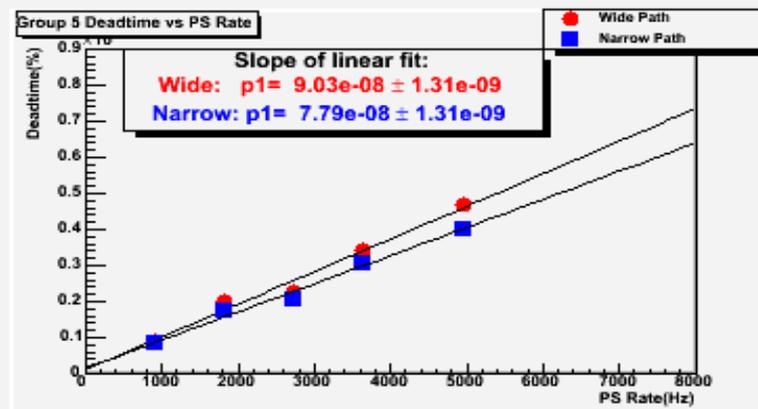
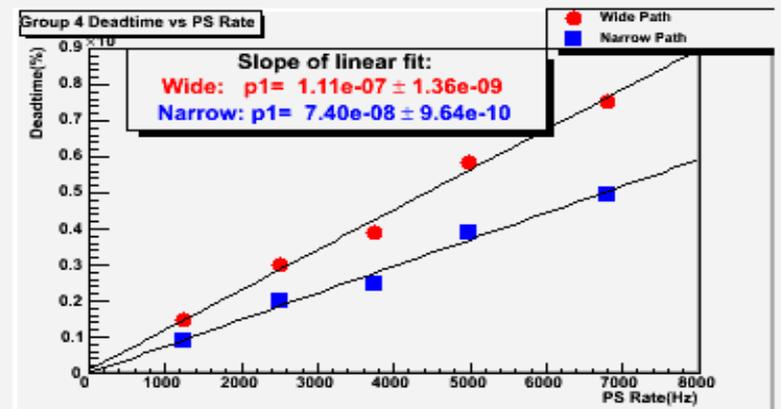
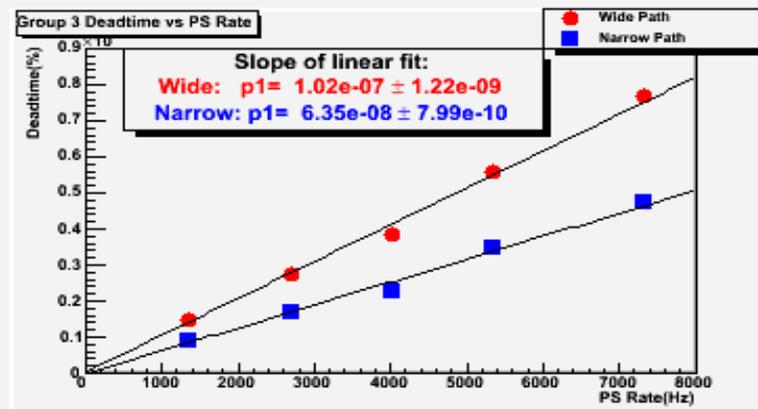
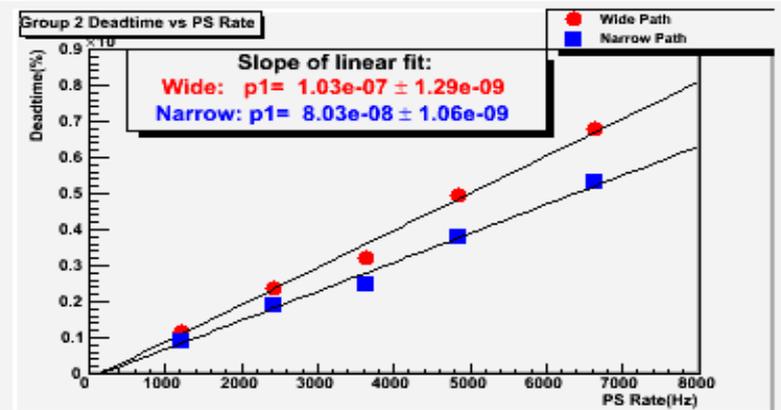
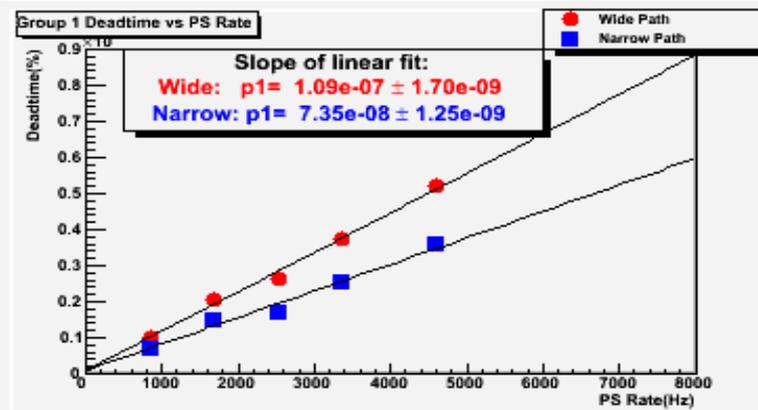
$$\text{Pileup}(\%) = \frac{\text{Red} + \text{Blue}}{\text{Black}}$$



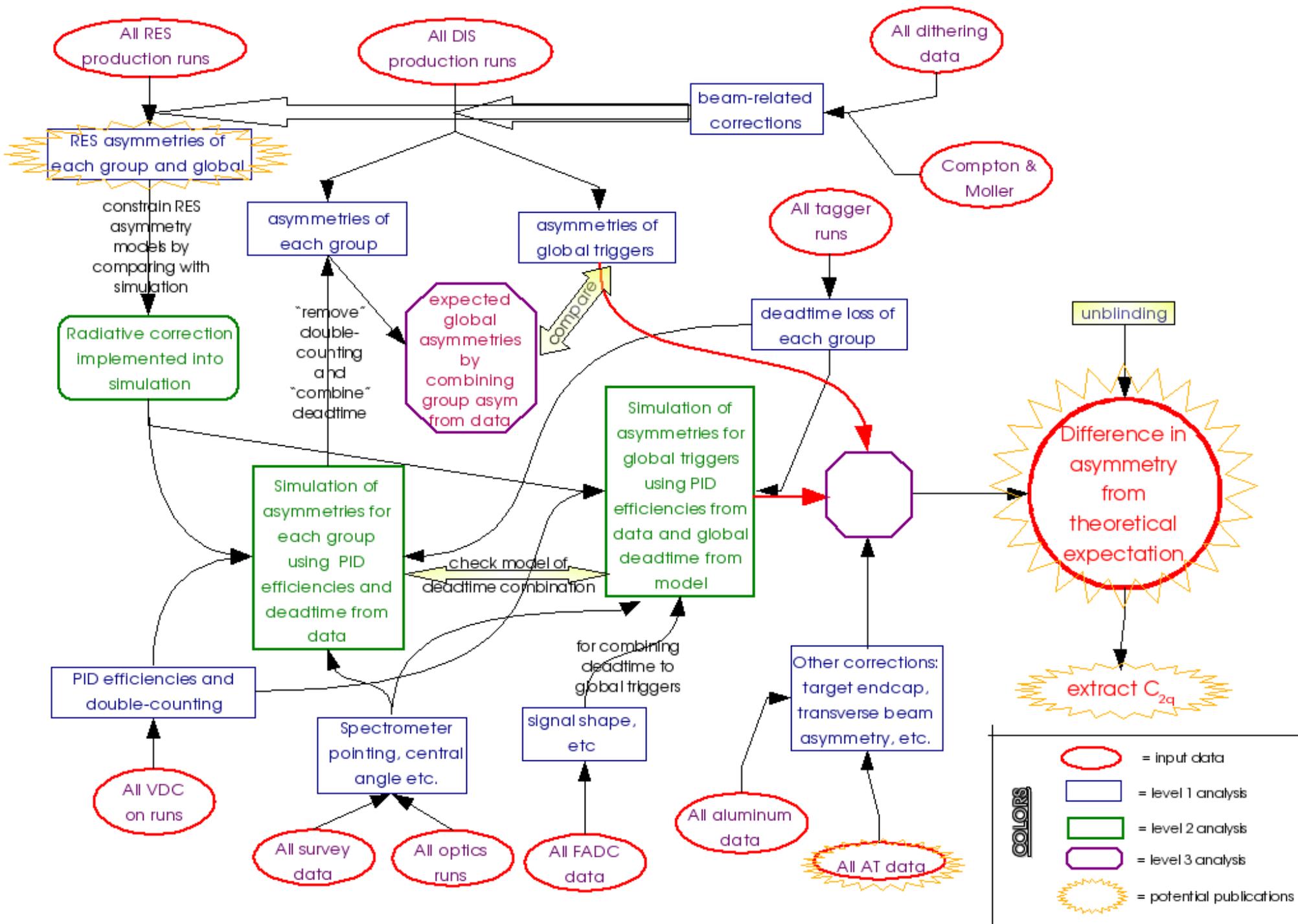
Deadtime Measurement



Deadtime Measurement



E08-011 PVDIS Analysis Flow Chart



Summary

● The Physics of PVDIS

$$A_{pv} \equiv \frac{\sigma^r - \sigma^l}{\sigma^r + \sigma^l} = \frac{(M_y + M_z^r)^2 - (M_y + M_z^l)^2}{(M_y + M_z^r)^2 + (M_y + M_z^l)^2} \approx \frac{M_z^r - M_z^l}{M_y}$$

● Experimental Setup and General Run Information

● Online Results and Expected Uncertainties

● On-Going Data Analysis

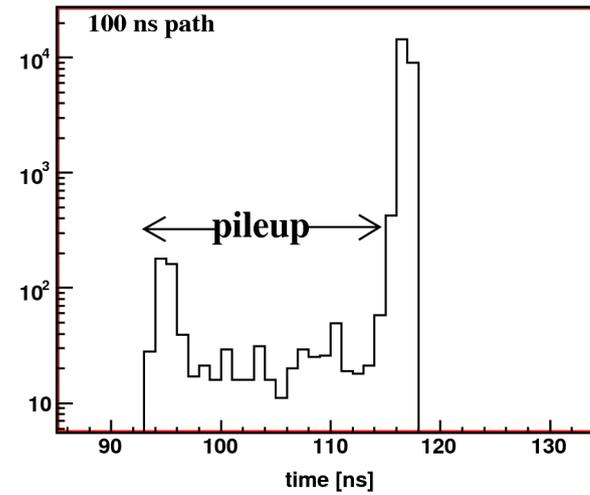
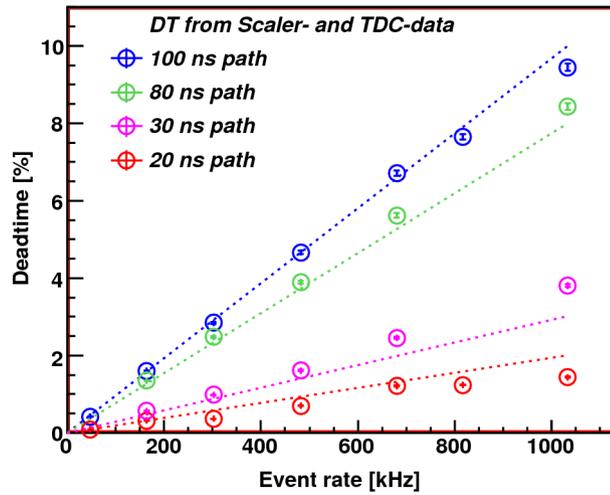
➔ BCM Calibration → **Need more thinking**

➔ Deadtime of the Fast-Counting DAQ

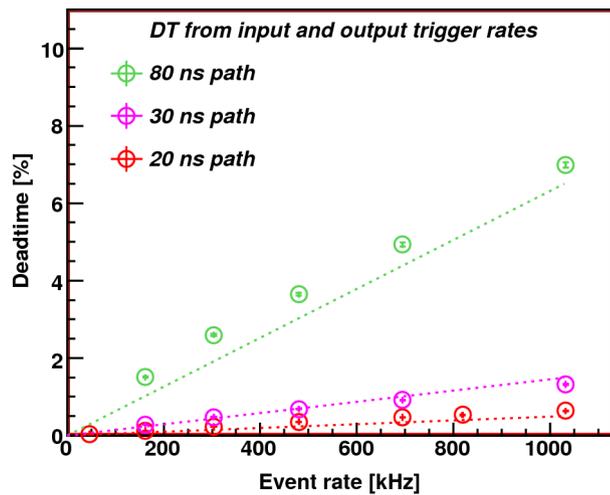
● Future Analysis goal

Deadtime measurement: from test and real data

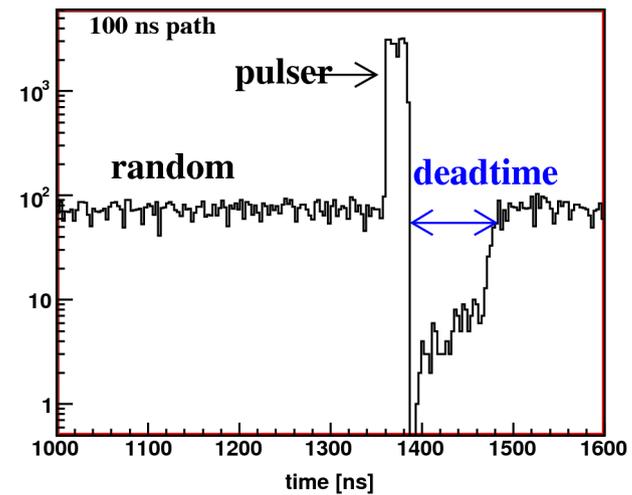
Method I



Method II



Method III



Kinematics

Kinematics	I	II
X_{bj}	0.25	0.3
Q^2 (GeV/c) ²	1.11	1.9
E_{beam} (GeV)	6.0	6.0
E' (GeV)	3.66	2.63
θ (°)	12.9°	20.0°
W^2 (GeV) ²	4.16	5.30
Y	0.470	0.716
R_C	<0.001	0.001
R_S	0.052	0.041
R_V	0.872	0.910
A_d (measured, ppm)	-91.3	-160.7
e^- rate/HRS (kHz)	269.8	25.1
π/e^- ratio	0.9	6.4
e^+/e^- ratio	0.073%	0.463%
Total rate/HRS (kHz)	513.0	186.2